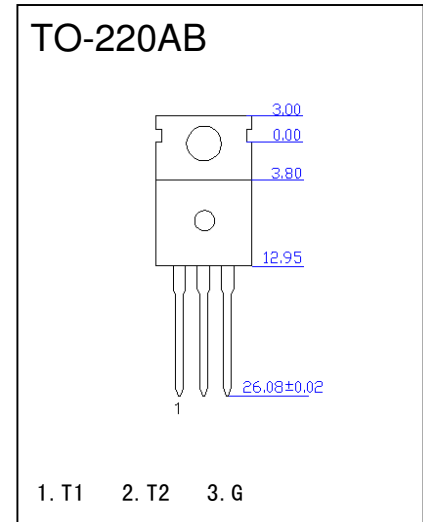


## STANDARD

Glass Passivated thyristor in a plastic envelope, intended for use in application blocking voltage capability and high thermal cycling performance. Typical applications include motor control, industrial, domestic lighting, heating and static switching.

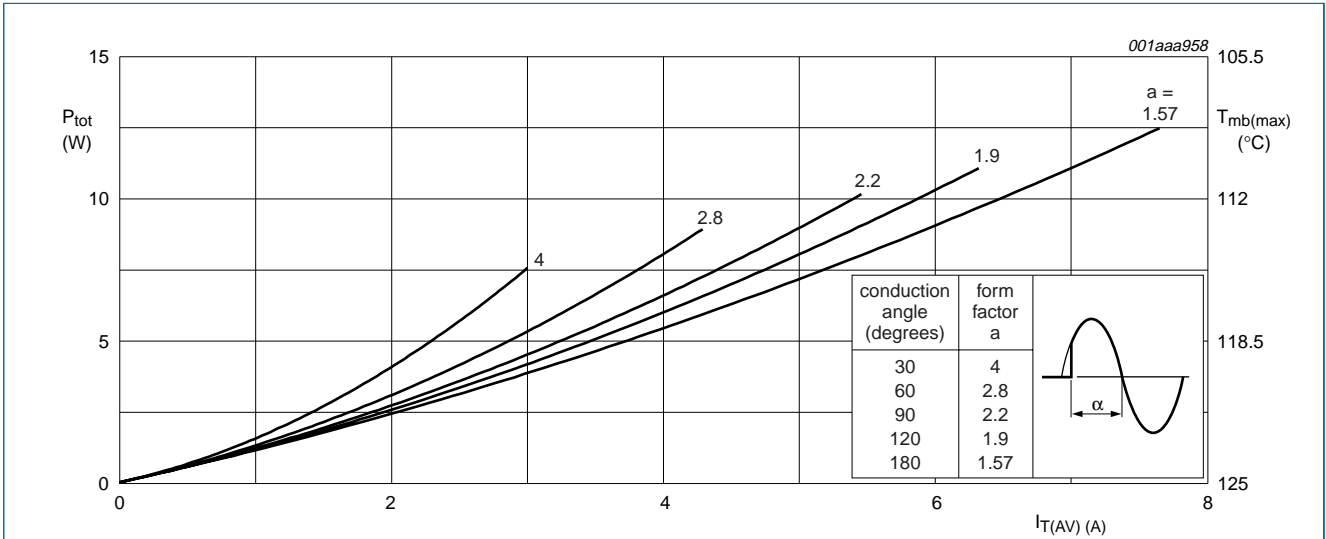
### △ ABSOLUTE MAXIMUM RATINGS (TA=25°C)

Characteristic	Symbol	Rating	Unit
Repetitive Peak off-state voltage	V <sub>DRM</sub>	650	V
RMS on-state current	I <sub>T (RMS)</sub>	7.5	A
Non-repetitive peak on-state current	I <sub>TSM</sub>	100	A
Peak gate power	P <sub>GM</sub>	5	W
Peak gate current	I <sub>GM</sub>	2	A
Junction Temperature	T <sub>J</sub>	125	°C
Storage Temperature	T <sub>STG</sub>	-40-150	°C



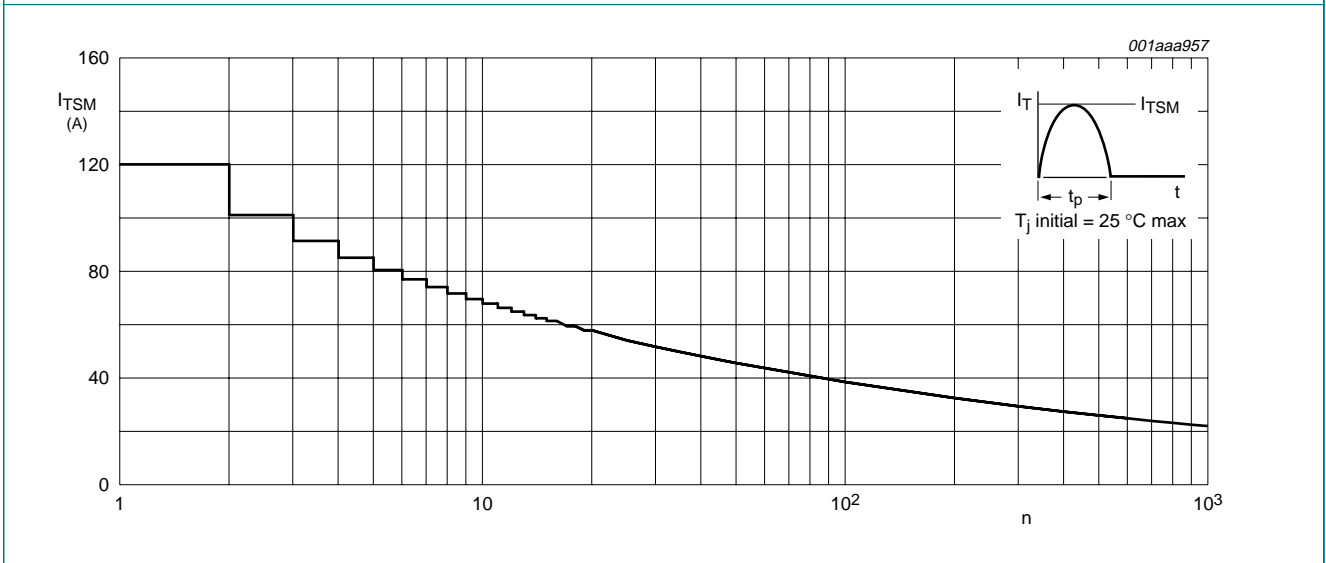
### △ ELECTRICAL CHARACTERISTICS (TA=25°C)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Repetitive Peak off-state voltage	V <sub>DRM</sub>		600			V
Gate trigger current	I <sub>GT</sub>	V <sub>D</sub> =12V; I <sub>T</sub> =0.1A		2	15	mA
Base-Emitter Saturation Voltage	I <sub>L</sub>	V <sub>D</sub> =12V; I <sub>GT</sub> =0.1A		10	40	
Holding current	I <sub>H</sub>	V <sub>D</sub> =12V; I <sub>GT</sub> =0.1A		7.0	20	mA
Gate trigger voltage	V <sub>GT</sub>	V <sub>D</sub> =V <sub>DRM(MAX)</sub> ; I <sub>T</sub> =0.1A; T <sub>j</sub> =125 °C	0.25	0.4		V
		V <sub>D</sub> =12V; I <sub>T</sub> =0.1A		0.6	1.5	V
Off-state leakage current	I <sub>D</sub> , I <sub>R</sub>	V <sub>D</sub> =V <sub>DRM(MAX)</sub> ; V <sub>R</sub> =V <sub>RRM(MAX)</sub> ; T <sub>j</sub> =125 °C		0.1	0.5	mA
On-state voltage	V <sub>T</sub>	I <sub>T</sub> =23A		1.4	1.75	V
Gate controlled turn-on time	T <sub>GT</sub>	I <sub>TM</sub> =40A; V <sub>D</sub> =V <sub>DRM(MAX)</sub> ; I <sub>G</sub> =0.1A; DI <sub>G</sub> /dt=5A/us		2		us



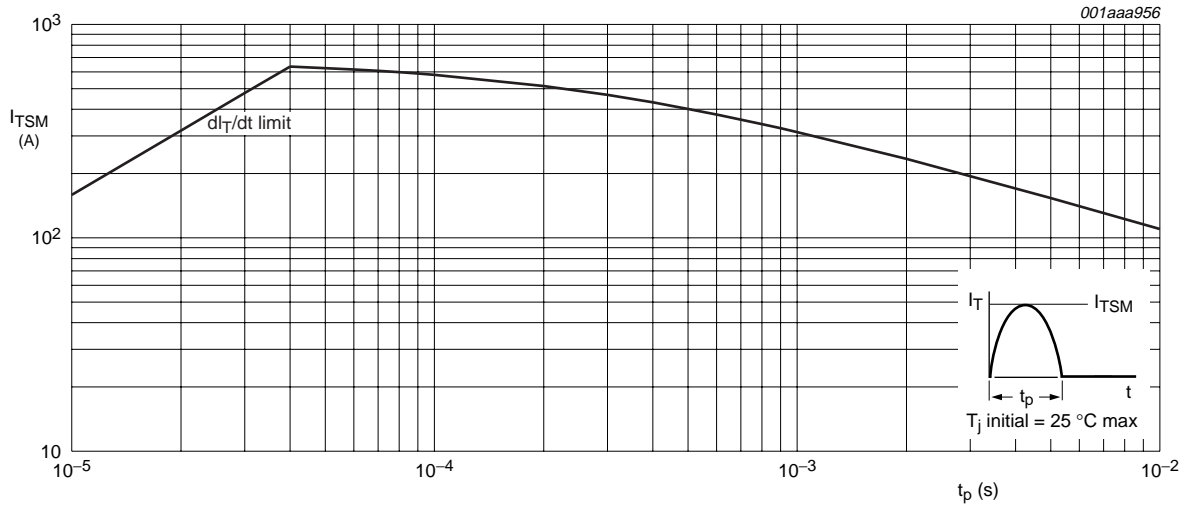
$a = \text{form factor} = I_{T(\text{RMS})} / I_{T(\text{AV})}$

Fig 1. Total power dissipation as a function of average on-state current; maximum values.



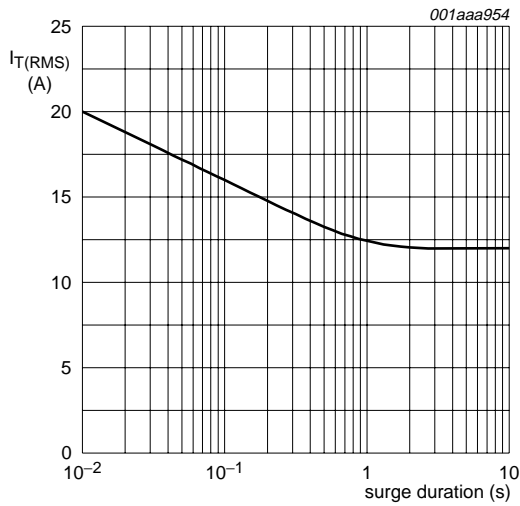
f = 50 Hz.

Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values.



$t_p \leq 10$  ms.

Fig 3. Non-repetitive peak on-state current as a function of pulse width; maximum values.



$f = 50$  Hz;  $T_{mb} \leq 109$  °C.

Fig 4. RMS on-state current as a function of surge duration; maximum values.

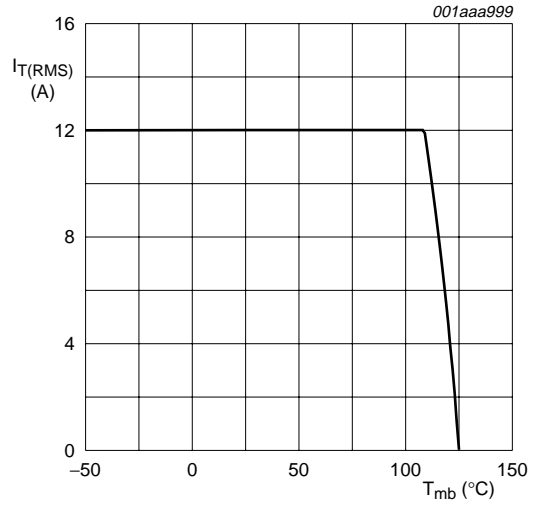


Fig 5. RMS on-state current as a function of mounting base temperature; maximum values.

**Table 4: Thermal characteristics**

Symbol	Parameter	Conditions	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	<a href="#">Figure 6</a>	-	1.3	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	60	-	K/W

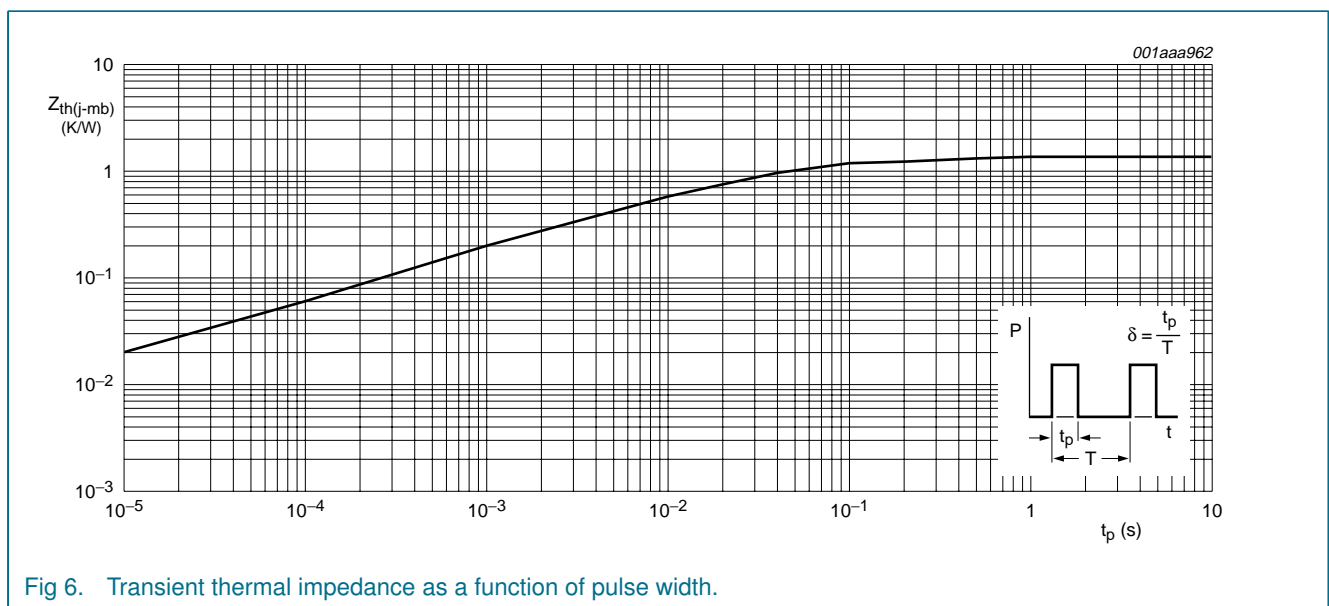


Fig 6. Transient thermal impedance as a function of pulse width.

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise stated

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
$I_{GT}$	gate trigger current	$V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; <a href="#">Figure 8</a>	-	2	15	mA
$I_L$	latching current	$V_D = 12\text{ V}$ ; $I_{GT} = 0.1\text{ A}$ ; <a href="#">Figure 10</a>	-	10	40	mA
$I_H$	holding current	$V_D = 12\text{ V}$ ; $I_{GT} = 0.1\text{ A}$ ; <a href="#">Figure 11</a>	-	7	20	mA
$V_T$	on-state voltage	$I_T = 23\text{ A}$ ; <a href="#">Figure 9</a>	-	1.4	1.75	V
$V_{GT}$	gate trigger voltage	$V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; <a href="#">Figure 7</a>	-	0.6	1.5	V
		$V_D = V_{DRM(max)}$ ; $I_T = 0.1\text{ A}$ ; $T_j = 125\text{ }^\circ\text{C}$	0.25	0.4	-	V
$I_{D, IR}$	off-state leakage current	$V_D = V_{DRM(max)}$ ; $V_R = V_{RRM(max)}$ ; $T_j = 125\text{ }^\circ\text{C}$	-	0.1	0.5	mA
<b>Dynamic characteristics</b>						
$dV_D/dt$	critical rate of rise of off-state voltage	$V_{DM} = 67\% V_{DRM(max)}$ ; $T_j = 125\text{ }^\circ\text{C}$ ; exponential waveform; <a href="#">Figure 12</a>				
		gate open circuit	50	130	-	V/nS
		$R_{GK} = 100\text{ W}$	200	1000	-	V/nS
$t_{gt}$	gate controlled turn-on time	$I_{TM} = 40\text{ A}$ ; $V_D = V_{DRM(max)}$ ; $I_G = 0.1\text{ A}$ ; $dI_G/dt = 5\text{ A/nS}$	-	2	-	nS
$t_q$	circuit commuted turn-on time	$V_D = 67\% V_{DRM(max)}$ ; $T_j = 125\text{ }^\circ\text{C}$ ; $I_{TM} = 20\text{ A}$ ; $V_R = 25\text{ V}$ ; $dI_{TM}/dt = 30\text{ A/nS}$ ; $dV_D/dt = 50\text{ V/nS}$ ; $R_{GK} = 100\text{ W}$	-	70	-	nS

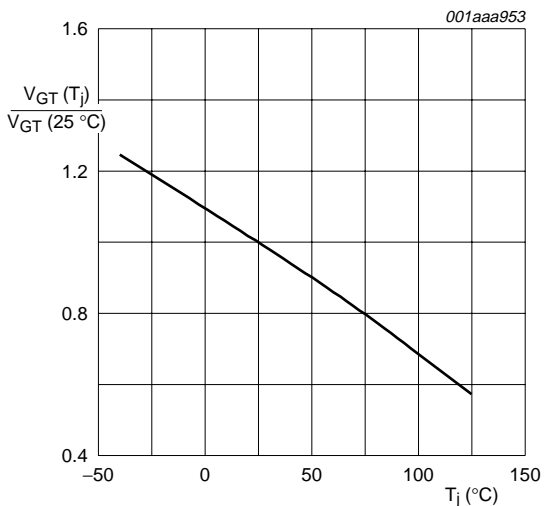


Fig 7. Normalized gate trigger voltage as a function of junction temperature.

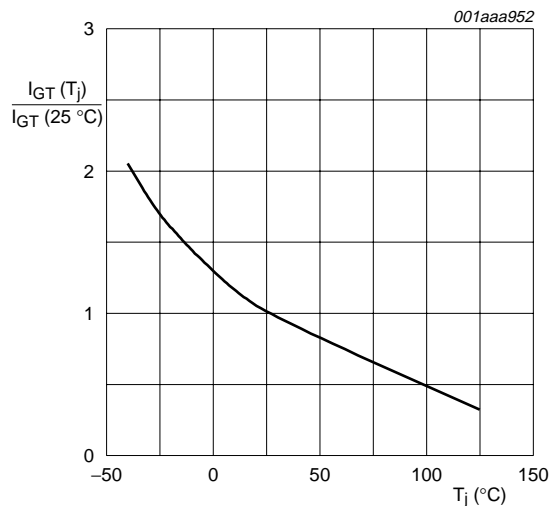
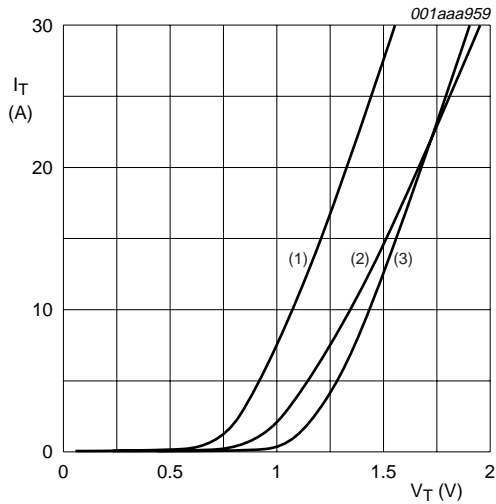


Fig 8. Normalized gate trigger current as a function of junction temperature.

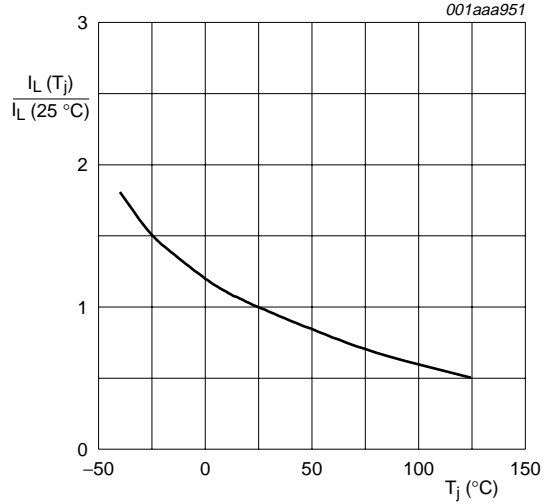


$V_O = 1.06 \text{ V}$ .

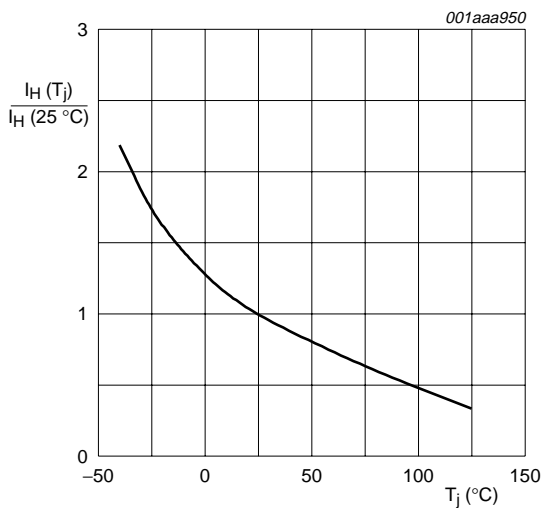
$R_S = 0.0304 \text{ W}$ .

- (1)  $T_j = 125 \text{ }^\circ\text{C}$ ; typical values.
- (2)  $T_j = 125 \text{ }^\circ\text{C}$ ; maximum values.
- (3)  $T_j = 25 \text{ }^\circ\text{C}$ ; maximum values.

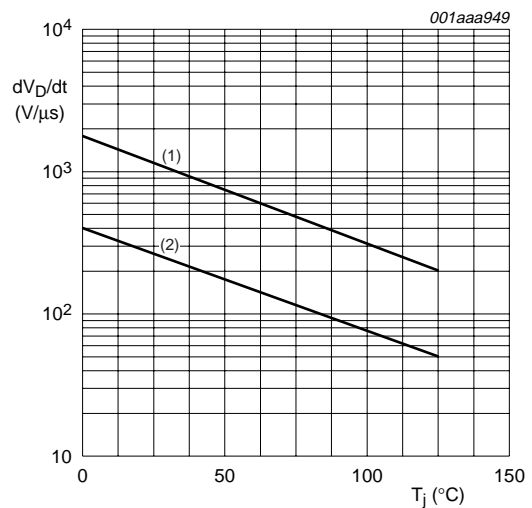
**Fig 9. On-state current characteristics.**



**Fig 10. Normalized latching current as a function of junction temperature.**



**Fig 11. Normalized holding current as a function of junction temperature.**



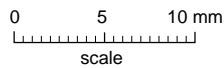
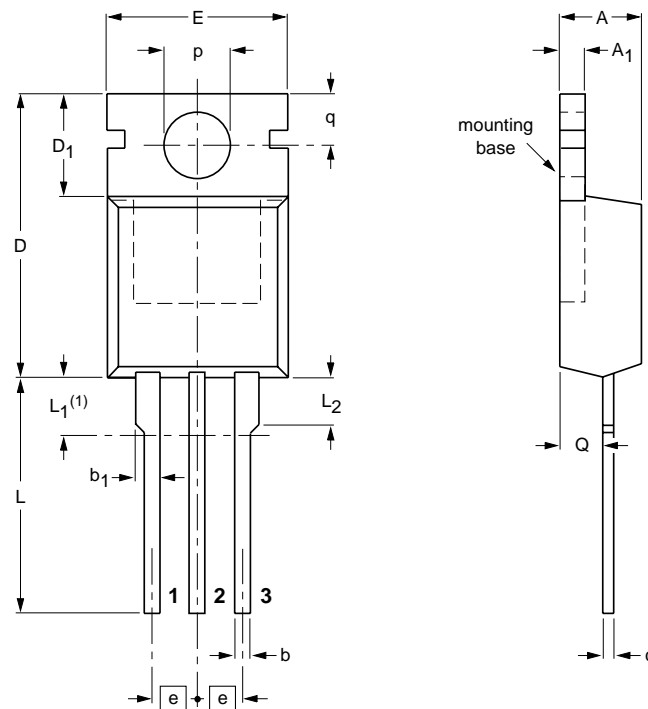
(1)  $R_{GK} = 100 \text{ } \Omega$ .

(2) Gate open circuit.

**Fig 12. Critical rate of rise of off-state voltage as a function of junction temperature; minimum values.**

**PACKAGE OUTLINE**


Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

**SOT78**

**DIMENSIONS (mm are the original dimensions)**

UNIT	A	A <sub>1</sub>	b	b <sub>1</sub>	c	D	D <sub>1</sub>	E	e	L	L <sub>1</sub> <sup>(1)</sup>	L <sub>2</sub> max.	p	q	Q
mm	4.5	1.39	0.9	1.3	0.7	15.8	6.4	10.3	2.54	15.0	3.30	3.0	3.8	3.0	2.6
	4.1	1.27	0.6	1.0	0.4	15.2	5.9	9.7		13.5	2.79		3.6	2.7	2.2

**Note**

1. Terminals in this zone are not tinned.

OUTLINE VERSION	REFERENCES			EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA		
SOT78		3-lead TO-220AB	SC-46		01-02-16 03-01-22